

Notice of References Cited

Application/Control No.

09/530,553

Applicant(s)/Patent Under
Reexamination
DEBOY ET AL.

Examiner

Paul E Brock II

Art Unit

2815

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,521,105 /	05-1996	Hsu et al.	438/197
	B	US-5,883,413	03-1999	Ludikhuize, Adrianus W.	257/343
	C	US-6,207,994 /	03-2001	Rumennik et al.	257/339
	D	US-5,930,630 /	07-1999	Hshieh et al.	438/268
	E	US-6,236,068 /	05-2001	Feiler, Wolfgang	257/133
	F	US-5,610,432 /	03-1997	Ludikhuize, Adrianus W.	257/212
	G	US-5,032,878 /	07-1991	Davies et al.	257/491
	H	US-4,300,150 /	11-1981	Colak, Sel	257/336
	I	US-5,028,548 /	07-1991	Nguyen, Minh-Chau	148/DIG.13
	J	US-4,609,929 /	09-1986	Jayaraman et al.	257/336
	K	US-5,347,155 /	09-1994	Ludikhuize, Adrianus W.	257/489
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 19730328 C1 /	12-1998	Germany	TIHANYI, JENOE DR ING	H01L 29/06
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.